## Notice of References Cited Application/Control No. 10/586,620 Examiner Thai Phan Applicant(s)/Patent Under Reexamination YONEDA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,120,572	10-2006	Liang, Sheng	703/26
*	В	US-7,251,594	07-2007	Krishnan, Sivaram	703/26
*	С	US-7,120,572	10-2006	Liang, Sheng	703/26
*	D	US-6,871,298	03-2005	Cavanaugh et al.	714/33
*	Е	US-7,228,266	06-2007	Sollom et al.	703/26
	F	US-			
	O	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р		A			
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9	R					
	s					
			A		100	

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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